

**Erratum: “Synthesis, characterization and ferroelectric properties of lead-free  $K_{0.5}Na_{0.5}NbO_3$  nanotube arrays” [J. Appl. Phys. 109, 114104 (2011)]**

Di Zhou, Haoshuang Gu, Yongming Hu, Huyong Tian, ZhaoWang et al.

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Di Zhou,<sup>1,2</sup> Haoshuang Gu,<sup>2</sup> Yongming Hu,<sup>1,2</sup> Huyong Tian,<sup>2,3</sup> ZhaoWang,<sup>2</sup> Zheli Qian,<sup>2</sup> and Yu Wang<sup>1</sup>

<sup>1</sup>*Department of Applied Physics and Materials Research Center, The Hong Kong Polytechnic University, Hong Kong SAR, China*

<sup>2</sup>*Key Lab of Ferro- and Piezoelectric Materials and Devices of Hubei Province, Faculty of Physics and Electronic Technology, Hubei University, Wuhan 430062, China*

<sup>3</sup>*Department of Imaging and Applied Physics, Curtin University, GPO Box U 1987, Perth 6845, WA, Australia*

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